Document Number: MC33395 Rev 4.0, 2/2007

Three-Phase Gate Driver IC

The 33395 simplifies the design of high-power BLDC motor control design by combining the gate drive, charge pump, current sense, and protection circuitry necessary to drive a three-phase bridge configuration of six N-channel power MOSFETs. Mode logic is incorporated to route a pulse width modulation (PWM) or a complementary PWM output signal to either low-side or high-side MOSFETs of the bridge.

Detection and drive circuitry are also incorporated to control a reverse battery protection high-side MOSFET switch. PWM frequencies up to 28 kHz are possible. Built-in protection circuitry prevents damage to the MOSFET bridge as well as the drive IC and includes overvoltage shutdown, overtemperature shutdown, overcurrent shutdown, and undervoltage shutdown.

The device is parametrically specified over ambient temperature range of -40°C \leq $T_A \leq$ 125°C and 5.5 V \leq V $_{IGN} \leq$ 24 V supply.

Features

- Drives Six N-Channel Low PDS(ON) Power MOSFETs
- Built-In Charge Pump Circuitry
- Built-In Current Sense Compaator and Output Drive Current Limiting
- Built-In PWM Mode Control Logic
- Built-In Circuit Protection
- · Designed for Fractional to Integral HP BLDC Motors
- 32-Pin SOIC Wide Body Surface Mount Package
- 33395 Incorporates a <5.0µs Shoot-Through Suppression Timer
- 33395T Incorporates a <1.0µs Shoot-Through Suppression Timer
- Pb-Free Packaging Designated by Suffix Code EW

33395 33395T

THREE-PHASE GATE DRIVER IC



DWB SUFFIX EW SUFFIX (Pb-FREE) 98ARH99137A 32-PIN SOICW

| ORDERING INFORMATION | | | | | | | |
|----------------------|--|-----------------------|--|--|--|--|--|
| Device | Temperature Range (T _A) | Package | | | | | |
| MC33395DWB/R2 | | 32 SOICW | | | | | |
| MC33395EW/R2 | | 32 SOICW | | | | | |
| MCZ33395EW/R2 | -40℃ to 125℃ | (Pb-Free) | | | | | |
| MC33395TDWB/R2 | | 32 SOICW | | | | | |
| MC33395TEW/R2 | | 32 SOICW (Pb-Free) | | | | | |

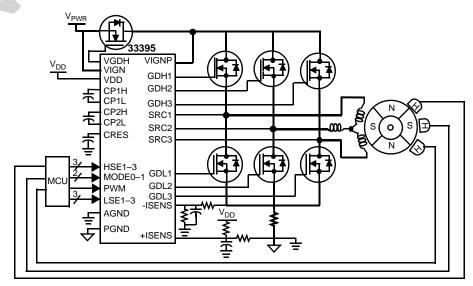


Figure 1. 33395 Simplified Application Diagram



^{*} This document contains certain information on a new product.

Specifications and information herein are subject to change without notice.

INTERNAL BLOCK DIAGRAM

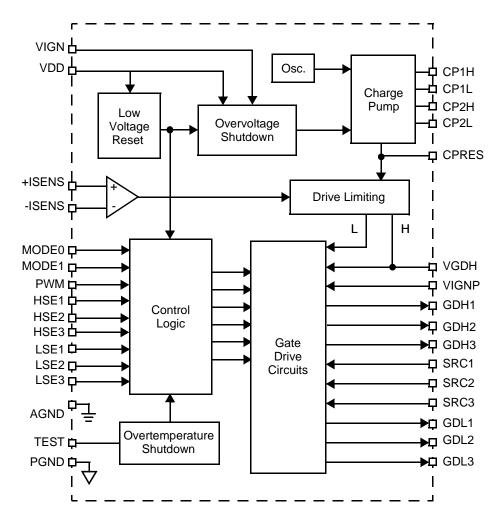


Figure 2. 33395 Simplified Internal Block Diagram

PIN CONNECTIONS

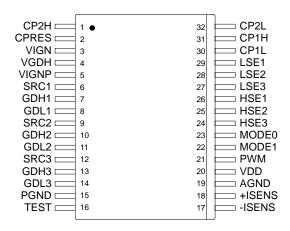


Figure 3. 33395 Pin Connections

Table 1. 33395 Pin Definitions

A functional description of each pin can be found in the Functional Pin Description section beginning on page 9.

| Pin Number | Pin Name | Pin Function | Formal Name | Definition |
|------------|----------|--------------|----------------------------|---|
| 1 | CP2H | | Charge Pump Cap | High potential pin connection for secondary charge pump capacitor |
| 2 | CPRES | Input | Charge Pump Reserve Cap | Input from external reservoir capacitor for charge pump |
| 3 | VIGN | Input | Input Voltage | Input from ignition level supply voltage for power functions |
| 4 | VGDH | Output | High-Side Gate Voltage | Output full-time gate drive for auxiliary high-side power MOSFET switch |
| 5 | VIGNP | Input | Input Voltage Protected | Input from protected ignition level supply for power functions |
| 6 | SRC1 | Sensor | High-Side Sense | Sense for high-side source voltage, phase 1 |
| 7 | GDH1 | Output | Gate Drive High | Output for gate high-side, phase 1 |
| 8 | GDL1 | Output | Output for Gate | Output for gate drive low-side, phase 1 |
| 9 | SRC2 | Sensor | High-Side Sense | Sense for high-side source voltage, phase 2 |
| 10 | GDH2 | Output | Gate Drive High | Output for gate high-side, phase 2 |
| 11 | GDL2 | Output | Output for Gate | Output for gate drive low-side, phase 2 |
| 12 | SRC3 | Sensor | High-Side Sense | Sense for high-side source voltage, phase 3 |
| 13 | GDH3 | Output | Gate Drive High | Output for gate drive high-side, phase 3 |
| 14 | GDL3 | Output | Gate Drive Low | Output for gate drive low-side, phase 3 |
| 15 | PGND | Ground | Power Ground | Ground pins for power functions |
| 16 | Test | N/A | Test Pin | This should be connected to ground or left open |
| 17 | -ISENS | Input | IS Minus | Inverting input for current limit comparator |
| 18 | +ISENS | Input | IS Plus | Non-inverting input for current limit comparator |
| 19 | AGND | Ground | Analog Ground | Ground pin for logic functions |
| 20 | VDD | Power | Logic Supply Voltage | Supply voltage for logic functions |
| 21 | PWM | Input | Pulse Width Modulator | Input for pulse width modulated driver duty cycle |

Table 1. 33395 Pin Definitions (continued)

A functional description of each pin can be found in the Functional Pin Description section beginning on page 9.

| Pin Number | Pin Name | Pin Function | Formal Name | Definition |
|------------|----------|--------------|----------------------------|---|
| 22 | MODE1 | Input | Mode Control Bit 1 | Input for mode control selection |
| 23 | MODE0 | Input | Mode Control Bit 0 | Input for mode control selection |
| 24 | HSE3 | Input | High-Side Enable | Input for high-side enable logic, phase 3 |
| 25 | HSE2 | Input | High-Side Enable | Input for high-side enable logic, phase 2 |
| 26 | HSE1 | Input | High-Side Enable | Input for high-side enable logic, phase 1 |
| 27 | LSE3 | Input | Low-Side Enable | Input for low-side enable logic, phase 3 |
| 28 | LSE2 | Input | Low-Side Enable | Input for low-side enable logic, phase 2 |
| 29 | LSE1 | Input | Low-Side Enable | Input for low-side enable logic, phase 1 |
| 30 | CP1L | Input | External Pump Capacitor | Input from external pump capacitor for charge pump and secondary pins |
| 31 | CP1H | Input | External Pump Capacitor | Input from external pump capacitor for charge pump and secondary pins |
| 32 | CP2L | Input | Charge Pump Capacitor | Input from external reservoir, external pump capacitors for charge pump, and secondary pins |

ELECTRICAL CHARACTERISTICS

MAXIMUM RATINGS

Table 2. Maximum Ratings

All voltages are with respect to ground unless otherwise noted.

| Rating | Symbol | Value | Unit |
|--|--------------------------|-------------|------|
| VIGN Supply Voltage | V_{IGN} | -15.5 to 40 | VDC |
| VIGNP Load Dump Survival | V _{IGNPLD} | -0.3 to 65 | VDC |
| VDD Logic Supply Voltage (Fail Safe) | V _{DD} | -0.3 to 7.0 | VDC |
| Logic Input Voltage (LSEn, HSEn, PWM, and MODEn) | V _{IN} | 0.3 to 7.0 | VDC |
| Start Up Current V _{IGNP} | I _{VIGNSTARTUP} | 100 | mA |
| ESD Voltage (1) | | | V |
| Human Body Model | V _{ESD1} | ±500 | |
| Machine Model | V _{ESD2} | ±200 | |
| Storage Temperature | T _{STG} | -65 to 160 | C |
| Operating Ambient Temperature | T _A | -40 to 125 | ,C |
| Operating Case Temperature | T _C | -40 to 125 | £ |
| Maximum Junction Temperature | T _J | 150 | .C |
| Power Dissipation (T _A = 25℃) | P _D | 1.5 | W |
| Peak Package Reflow Temperature During Reflow (2), (3) | T _{PPRT} | Note 3 | , C |
| Thermal Resistance, Junction-to-Ambient | R_{\ThetaJA} | 65 | €\ M |

Notes

- 1. ESD1 testing is performed in accordance with the Human Body Model (C_{ZAP} = 100 pF, R_{ZAP} = 1500 Ω), ESD2 testing is performed in accordance with the Machine Model (C_{ZAP} = 200 pF, R_{ZAP} = 0 Ω).
- 2. Pin soldering temperature limit is for 10 seconds maximum duration. Not designed for immersion soldering. Exceeding these limits may cause malfunction or permanent damage to the device.
- Freescale's Package Reflow capability meets Pb-free requirements for JEDEC standard J-STD-020C. For Peak Package Reflow Temperature and Moisture Sensitivity Levels (MSL), Go to www.freescale.com, search by part number [e.g. remove prefixes/suffixes and enter the core ID to view all orderable parts. (i.e. MC33xxxD enter 33xxx), and review parametrics.

STATIC ELECTRICAL CHARACTERISTICS

Table 3. Static Electrical Characteristics

Characteristics noted under conditions -40°C \leq T_A \leq 125°C, 5.5 V \leq V_{IGNP} \leq 24 V unless otherwise noted. Typical values reflect approximate parameter mean at T_A = 25°C under normal conditions unless otherwise noted.

| Characteristic | Symbol | Min | Тур | Max | Unit |
|---|--|------------------|-------------------|----------------------|-----------------|
| POWER INPUT | | | | 1 | · |
| V _{IGN} Current @ 5.5 V-24 V, V _{DD} = 5.5 V | I _{IGN} | _ | 0.2 | 1.0 | mA |
| V _{IGNP} Current @ 5.5 V-24 V, V _{DD} = 5.5 V | I _{IGNP} | _ | _ | 100 | mA |
| V _{IGNP} Overvoltage Shutdown | V _{IGNPSD} | 25 | 33 | 36.5 | V |
| V _{IGNP} Voltage | V_{IGNP} | 5.5 | _ | 24 | V |
| V_{DD} Current @ 5.5 VDC, 5.5 V \leq $V_{IGNP} \leq$ 24 V | $I_{V_{DD}}$ | _ | 1.8 | 4.0 | mA |
| V _{DD} Low-Voltage Reset Level | V _{DD(RESET)} | 2.5 | 3.2 | 4.0 | V |
| V _{DD} One-Time Fuse (Logic Supply) | - | 7.0 | _ | _ | V |
| INPUT/OUTPUT | | | | | |
| Input Current at V _{DD} = 5.5 V LSEn, HSEn, PWM, and MODEn = 3.0 V | I _{IN} | 5.0 | 12 | 25 | μА |
| Input Threshold at V _{DD} = 5.5 V LSEn, HSEn, PWM, and MODEn ⁽⁴⁾ | V _{TH} | 1.0 | 2.0 | 3.0 | V |
| V _{SCRn} Source Sense Voltage SRC1, SRC2, SRC3 | V _{SCRn} | -0.3 | V _{IGNP} | 24 | V |
| Comparator Input Offset Voltage | V _{INP(OFFSET)} | 5.0 | 14 | 20 | mV |
| Comparator Input Bias Current | V _{INP(BIAS)} | -500 | -170 | 500 | nA |
| Comparator Input Offset Current | I _{INP(OFFSET)} | -300 | -3.0 | 300 | nA |
| Common Mode Voltage (5) | V_{CMR} | 0 | _ | V _{DD} -2.0 | V _{DC} |
| Comparator Differential Input Voltage (5) | V _{INPdiff} | -V _{DD} | _ | +V _{DD} | V |
| Charge Pump Voltage V _{IGN} ⁽⁶⁾ V _{IGNP} = 5.5 V, I _{CRES} = 1.0 mA | V _{CRES} -V _{IGNP} | 4.0 | 6.0 | 18 | V |
| $V_{IGNP} = 9.0 \text{ V}, I_{CRES} = 1.0 \text{ mA}$ | | 4.0 | 7.5 | 18 | |
| $V_{IGNP} = 12 \text{ V}, I_{CRES} = 5.0 \text{ mA}$ | | 4.5 | 10 | 18 | |
| $V_{IGNP} = 24 \text{ V}, I_{CRES} = 1.0 \text{ mA}$ | | 8.0 | 16 | 18 | |
| $V_{IGNP} = 24 \text{ V}, I_{CRES} = 5.0 \text{ mA}$ | | 4.5 | 12 | 18 | |
| V_{GDH} Output Voltage with GDHn in ON State $V_{IGNP} = 5.5 \text{ V}$, $I_{GDHn} = 1.0 \text{ mA}$ $V_{IGNP} = 12 \text{ V}$, $I_{GDHn} = 5.0 \text{ mA}$ | V _{GDHn(on)} -V _{SRCn} | 4.0 4.0 | 5.2 9.0 | 18 18 | V |
| $V_{IGNP} = 12 \text{ V}, I_{GDHn} = 3.0 \text{ mA}$ $V_{IGNP} = 24 \text{ V}, I_{GDHn} = 5.0 \text{ mA}$ | | 4.0 4.5 | 9.0 | 18 | |
| V _{GDH} Output Voltage with GDHn in OFF State V _{IGNP} = SRCn = 14 V, I _{GDHn} = 1.0 mA | V _{GDHn(off)} | -1.0 | 0.6 | 1.0 | V |

Notes

- 4. Logic inputs LSEn, HSEn, PWM, and MODEn have internal 20 μA internal sinks.
- 5. Guaranteed by design and characterization. Not production tested.
- 6. The Charge Pump has a positive temperature coefficient. Therefore the Min's occur at -40°C, Typ's at 25°C, and Max's at 125°C.

Table 3. Static Electrical Characteristics (continued)

Characteristics noted under conditions -40°C \leq T_A \leq 125°C, 5.5 V \leq V_{IGNP} \leq 24 V unless otherwise noted. Typical values reflect approximate parameter mean at T_A = 25°C under normal conditions unless otherwise noted.

| Characteristic | Symbol | Min | Тур | Max | Unit |
|---|-----------------------|------|-----|-----|----------|
| INPUT/OUTPUT (CONTINUED) | | 1 | • | | . |
| V _{GDL} Low-Side Output Voltage GDHn in ON State | V _{GDL(on)} | | | | V |
| $V_{IGNP} = 5.5 \text{ V}, I_{GDLn} = 1.0 \text{ mA}$ | , , | 5.0 | 8.0 | 18 | |
| $V_{IGNP} = 12 \text{ V}, I_{GDLn} = 5.0 \text{ mA}$ | | 8.0 | 14 | 18 | |
| $V_{IGNP} = 24 \text{ V}, I_{GDLn} = 0.0 \text{ mA}$ | | 8.0 | 17 | 19 | |
| $V_{IGNP} = 24 \text{ V}, I_{GDLn} = 5.0 \text{ mA}$ | | 8.0 | 16 | 19 | |
| V _{GDL} Output Voltage GDHn in OFF State | V _{GDL(off)} | | | | V |
| $V_{IGNP} = 14 \text{ V}, I_{GDLn} = 1.0 \text{ mA}$ | | -1.0 | 0.3 | 1.0 | |
| Thermal Shutdown (7) | T _{LIM} | 160 | - | 190 | C |

Notes

^{7.} Guaranteed by design and characterization. Not production tested.

DYNAMIC ELECTRICAL CHARACTERISTICS

Table 4. Dynamic Electrical Characteristics

Characteristics noted under conditions -40°C \leq $T_{A} \leq$ 125°C, 5.5 V \leq $V_{IGNP} \leq$ 24 V unless otherwise noted. Typical values reflect approximate parameter mean at T_{A} = 25°C under normal conditions unless otherwise noted.

| Characteristic | Symbol | Min | Тур | Max | Unit |
|--|----------------------------------|-----|------|-----|------|
| High-Side (GDHn) and Low-Side Drivers (GDHn) Rise Time (25% to 75%), C _{ISS} Value = 2000 pF ⁽⁸⁾ | t _{RH} | - | 0.35 | 1.5 | μS |
| High-Side (GDHn) and Low-Side Drivers (GDHn) Fall Time (75% to 25%), C _{ISS} Value = 2000 pF ⁽⁸⁾ | t _{FH} | - | 0.25 | 1.5 | μS |
| Shoot-Through Suppression Time Delay (33395) (8), (9) | t _{D1,} t _{D2} | | | | μs |
| 33395 | | 1.0 | 3.0 | 5.5 | |
| 33395T | | 0.2 | 0.65 | 1.0 | |
| Current Limit Time Delay (10) | t _{ILIMDELAY} | 1.5 | 2.8 | 5.0 | μS |

Notes

- 8. See <u>Figure 4</u>, page <u>8</u>.
- 9. Shoot-Through Suppression Time Delay is provided to prevent directly connected high- and low-side MOSFETs from being on simultaneously.
- 10. Current Limit Time Delay: The internal comparator places the device in the current limit mode when the comparator output goes LOW and sets an internal logic bit. This takes a finite amount of time and is stated as the Current Limit Time Delay.

TIMING DIAGRAM

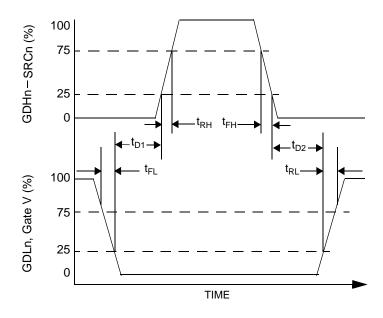


Figure 4. Shoot-Through Suppression

FUNCTIONAL DESCRIPTION

INTRODUCTION

The 33395 and 33395T devices are designed to provide the necessary drive and control signal buffering and amplification to enable a DSP or MCU to control a threephase array of power MOSFETs such as would be required to energize the windings of powerful brushless DC (BLDC) motors. It contains built-in charge pump circuitry so that the MOSFET array may consist entirely of N-Channel MOSFETs. It also contains feedback sensing circuitry and control circuitry to provide a robust overall motor control design.

FUNCTIONAL PIN DESCRIPTION

CHARGE PUMP CAPACITOR (CP2H)

High potential pin connection for secondary charge pump capacitor

CHARGE PUMP RESERVE CAPACITOR (CPRES)

Input from external reservoir capacitor for charge pump

INPUT VOLTAGE (VIGN)

Input from ignition level supply voltage for power functions

HIGH-SIDE GATE VOLTAGE (VGDH)

Output full-time gate drive for auxiliary high-side power MOSFET switch

INPUT VOLTAGE PROTECTED (VIGNP)

Input from protected ignition level supply for power functions

HIGH-SIDE SENSE (SRC1, SRC2, SRC3)

Sense for high-side source voltage, phase 1/2/3

GATE DRIVE HIGH (GDH1, GDH2, GDH3)

Output for gate high-side, phase 1/2/3

OUTPUT FOR GATE (GDL1, GDL2, GDL3)

Output for gate drive low-side, phase 1

POWER GROUND (PGND)

Ground pins for power functions

TEST PIN (TEST)

This should be connected to ground or left open

IS MINUS (-ISENS)

Inverting input for current limit comparator

IS PLUS (+ISENS)

Non-Inverting input for current limit comparator

ANALOG GROUND (AGND)

Ground pin for logic functions

LOGIC SUPPLY VOLTAGE (VDD)

Supply voltage for logic functions

PULSE WIDTH MODULATOR (PWM)

Input for pulse width modulated driver duty cycle

MODE CONTROL BIT 1 (MODE1)

Input for mode control selection

MODE CONTROL BIT 0 (MODE0)

Input for mode control selection

HIGH-SIDE ENABLE (HSE3, HSE2, HSE1)

Input for high-side enable logic, phase 1/2/3

LOW-SIDE ENABLE (LSE3, LSE2, LSE1)

Input for low-side enable logic, phase 1/2/3

EXTERNAL PUMP CAPACITOR (CP1L, CP1H)

Input from external pump capacitor for charge pump and secondary pins

CHARGE PUMP CAPACITOR (CP2L)

Input from external reservoir, external pump capacitors for charge pump, and secondary pins

FUNCTIONAL INTERNAL BLOCK DESCRIPTION

GATE DRIVE CIRCUITS

The gate drive outputs (GDH1, GDH2, etc.) supply the peak currents required to turn ON and hold ON the MOSFETs, as well as turn OFF and hold OFF the MOSFETs.

CHARGE PUMP

The current capability of the charge pump is sufficient to supply the gate drive circuit's demands when PWMing at up to 28 kHz. Two external charge pump capacitors and a reservoir capacitor are required to complete the charge pump's circuitry.

Charge reservoir capacitance is a function of the total MOSFET gate charge (Q_G) gate drive voltage level relative to the source (V_{GS}) and the allowable sag of the drive level during the turn-on interval (V_{SAG}). C_{RES} can be expressed by the following formula:

$$C_{RES} = \frac{Q_G \times V_{GS}}{2 \times V_{GS} \times V_{SAG} - V_{SAG}^2}$$

For example, for $Q_G = 60 \text{ nC}$, $V_{GS} = 14 \text{ V}$, $V_{SAG} = 0.2 \text{ V}$:

$$C_{RES} = \frac{(60 \text{ nC}) \text{ x } (14 \text{ V})}{2 \text{ x } (14 \text{ V}) \text{ x } (0.2 \text{ V}) - (0.2)^2} = 0.15 \text{ } \mu\text{F}$$

Proper charge pump capacitance is required to maintain, and provide for, adequate gate drive during high demand turn-ON intervals. Use the following formula to determine values for C_{P1} and C_{P2} :

For example, for the above determination of C_{RES} = 0.15 $\mu F\colon$

$$\frac{C_{RES}}{20} \le C_{P1} = C_{P2} \le \frac{C_{RES}}{10}$$

By averaging these two values, the proper C_{Pn} value can be determined:

$$\frac{0.15~\mu\text{F}}{20} = 0.075~\mu\text{F}, \text{ lower limit; and } \frac{0.15~\mu\text{F}}{10} = .015~\mu\text{F}, \text{ upper lim}$$

$$C_{P1}$$
 and C_{P2} =(0.0075 μF + 0.015 $\mu F) \div 2$ = 0.01 μF

THERMAL SHUTDOWN FUNCTION

The device has internal temperature sensing circuitry which activates a protective shutdown function should the die reach excessively elevated temperatures. This function effectively limits power dissipation and thus protects the device.

OVERVOLTAGE SHUTDOWN FUNCTION

When the supply voltage (V_{IGN}) exceeds the specified over- voltage shutdown level, the part will automatically shut down to protect both internal circuits as well as the load. Operation will resume upon return of V_{IGN} to normal operating levels.

LOW VOLTAGE RESET FUNCTION

When the logic supply voltage (V_{DD}) drops below the minimum voltage level or when the part is initially powered up, this function will turn OFF and hold OFF the external MOSFETs until the voltage increases above the minimum voltage level required for normal operation.

CONTROL LOGIC

The control logic block controls when the low-side and high-side drivers are enabled. The logic implements the Truth Table found in the specification and monitors the M0, M1, PWM, CL, OT, OV, LSE, and HSE pins. Note that the drivers are enabled 3 μs after the PWM edge. During complimentary chop mode the high-side and low-side drives are alternatively enabled and disabled during the PWM cycle. To prevent shoot-through current, the high-side drive turn-on is delayed by t_{D1} , and the low-side drive turn on is delayed by t_{D2} (see Figure 4, page 8).

Note that the drivers are disabled during an overtemperature or overvoltage fault. A flip-flop keeps the drive off until the following PWM cycle. This prevents erratic operation during fault conditions. The current limit circuit also uses a flip-flop for latching the drive off until the following PWM cycle.

Note PWM must be toggled after POR, Thermal Limit, <u>or</u> overvoltage faults to re-enable the gate drivers.

VGDH

The VGDH pin is used to provide a gate drive signal to a reverse battery protection MOSFET. If reverse battery protection is desired, $V_{\rm IGN}$ would be applied to the source of an external MOSFET, and the drain of the MOSFET would then deliver a "protected" supply voltage ($V_{\rm IGNP}$) to the three phase array of external MOSFETs as well as the supply voltage to the $V_{\rm IGNP}$ pin of the IC.

In a reverse polarity event (e.g., an erroneous installation of the system battery), the V_{GDH} signal will not be supplied to the external protection MOSFET, and the MOSFET will remain off and thus prevent reverse polarity from being applied to the load and the VIGNP supply pin of the IC.

HIGH-SIDE GATE DRIVE CIRCUITS

Outputs GDH1, GDH2, and GDH3 provide the elevated drive voltage to the high-side external MOSFETs (HS1, HS2, and HS3; see Figure 5, page 13). These gate drive outputs supply the peak currents required to turn ON and hold ON the high-side MOSFETs, as well as turn OFF the MOSFETs. These gate drive circuits are powered from an internal charge pump, and therefore compensate for voltage dropped across the load that is reflected to the source-gate circuits of the high-side MOSFETs.

LOW-SIDE GATE DRIVE CIRCUITS

Outputs GDL1, GDL2, and GDL3 provide the drive voltage to the low-side external MOSFETs (LS1, LS2, and LS3; see

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Figure 5). These gate drive outputs supply the peak currents required to turn ON and hold ON the low-side MOSFETs, as well as turn OFF the MOSFETs.

VDD FUSE

The V_{DD} supply of the 33395 IC has an internal fuse, which will blow and set all outputs of the device to OFF, if the V_{DD} voltage exceeds that stated in the maximum rating section of the data sheet. When this fuse blows, the device is permanently disabled.

I_{SENS} INPUTS

The +Isens and -Isens pins are inputs to the internal current sense comparator. In a typical application, these would receive a a low-pass filtered voltage derived from a current sense resistor placed in series with the ground return of the three-phase output bridge. When triggered by the comparator, the CL (current limit) bit of the internal error register is set, and the output gate drive pairs (i.e., GDH1 and GDL1, GDH2 and GDL2, GDH3 and GDL3), are controlled such that current will cease flowing through the load (refer to Table 5, Truth Table, page 12).

OVERTEMPERATURE AND OVERVOLTAGE SHUTDOWN CIRCUITS

Internal monitoring is provided for both over temperature conditions and over voltage conditions. When any of these conditions presents itself to the IC, the corresponding internally set bits of the error register are set, and the output gate drive pairs (i.e., GDH1 and GDL1, GDH2 and GDL2, GDH3 and GDL3), are controlled such that current will cease flowing through the load (refer to Table 5).

LSE AND HSE INPUT CIRCUITS

The low-side enable input pins (LSE1, LSE2, LSE3) and high-side enable input pins (HSE1, HSE2, HSE3) form the input pairs (HSE1 and LSE1, HSE2 and LSE2, HSE3 and LSE3) which set the logic states of the output gate drive pairs (i.e., GDH1 and GDL1, GDH2 and GDL2, GDH3 and GDL3) in accordance with the logic set forth in the Truth Table (page 12). Typically these inputs are supplied from an MCU or DSP to provide the phasing of the currents applied to a brushless dc motor's stator coils via the output MOSFET pairs.

PWM INPUT

The pulse width modulation input provides a single input pin to accomplish PWM modulation of the output pairs in accordance with the states of the Mode 0 and Mode 1 inputs as set forth in the Truth Table (page 12).

MODE SELECTION INPUTS

The mode selection inputs (Mode 0 and Mode 1) determine the PWM implementation of the output pairs in accordance with the logic set forth in the Truth Table (page 12). PWMing can thus be set to occur either on the high-side MOSFETs or the low-side MOSFETs, or can be set

to occur on both the high-side and low-side MOSFETs as "complementary chopping".

TEST PIN

This pin should be grounded or left floating (i.e., do not connect it to the printed circuit board). It is used by the automated test equipment to verify proper operation of the internal overtemperature shut down circuitry. This pin is susceptible to latch-up and therefore may cause erroneous operation or device failure if connected to external circuitry.

FUNCTIONAL DEVICE OPERATION

OPERATIONAL MODES

Table 5. Truth Table

The logic state of each output pair, GDLn and GDHn (n = 1, 2, 3), is a function of its corresponding input pair, LSEn and HSEn (n = 1, 2, 3), along with the logic states of the MODEn and PWM inputs and the internally set overtemperature shutdown (OT), overvoltage (OV), and current limit (CL) bits provided in this table.

NORMAL OPERATION

| Switchin | g Modes | Inter | Internally Set Bits | | Input Pairs (e.g., LSE2 and HSE2) | | Outpu (e.g., GDL2 | t Pairs and GDH2) |
|----------|---------|-------|---------------------|----|--------------------------------------|------|----------------------|----------------------|
| MODE1 | MODE0 | ОТ | OV | CL | LSEn | HSEn | GDLn | GDHn |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 |
| 0 | 0 | 0 | 0 | 0 | 1 | 0 | PWM | 0 |
| 0 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 0 |
| 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0 | 1 | 0 | 0 | 0 | 0 | 1 | 0 | 1 |
| 0 | 1 | 0 | 0 | 0 | 1 | 0 | PWM | PWM |
| 0 | 1 | 0 | 0 | 0 | 1 | 1 | 0 | 0 |
| 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 1 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | PWM |
| 1 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | 0 |
| 1 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 0 |
| 1 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 1 | 1 | 0 | 0 | 0 | 0 | 1 | PWM | PWM |
| 1 | 1 | 0 | 0 | 0 | 1 | 0 | 1 | 0 |
| 1 | 1 | 0 | 0 | 0 | 1 | 1 | 0 | 0 |

FAULT MODE OPERATION

| Switchin | g Modes | Inter | Internally Set Bits | | Input Pairs (e.g., LSE2 and HSE2) | | Outpu (e.g., GDL2 | t Pairs and GDH2) |
|----------|---------|-------|---------------------|----|--------------------------------------|------|----------------------|----------------------|
| MODE1 | MODE0 | OT | OV | CL | LSEn | HSEn | GDLn | GDHn |
| 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |
| 0 | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 1 |
| 0 | 0 | 0 | 0 | 1 | 1 | 0 | 0 | 0 |
| 0 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 0 |
| 0 | 1 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |
| 0 | 1 | 0 | 0 | 1 | 0 | 1 | 0 | 1 |
| 0 | 1 | 0 | 0 | 1 | 1 | 0 | 0 | 1 |
| 0 | 1 | 0 | 0 | 1 | 1 | 1 | 0 | 0 |
| 1 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |
| 1 | 0 | 0 | 0 | 1 | 0 | 1 | 0 | 0 |
| 1 | 0 | 0 | 0 | 1 | 1 | 0 | 1 | 0 |
| 1 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 0 |
| 1 | 1 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |
| 1 | 1 | 0 | 0 | 1 | 0 | 1 | 1 | 0 |
| 1 | 1 | 0 | 0 | 1 | 1 | 0 | 1 | 0 |
| 1 | 1 | 0 | 0 | 1 | 1 | 1 | 0 | 0 |
| Х | х | Х | 1 | Х | Х | Х | 0 | 0 |
| х | х | 1 | Х | Х | х | х | 0 | 0 |

TYPICAL APPLICATIONS

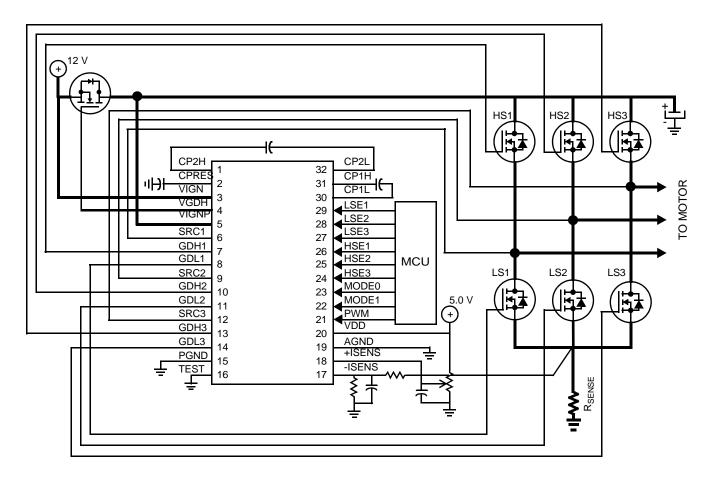
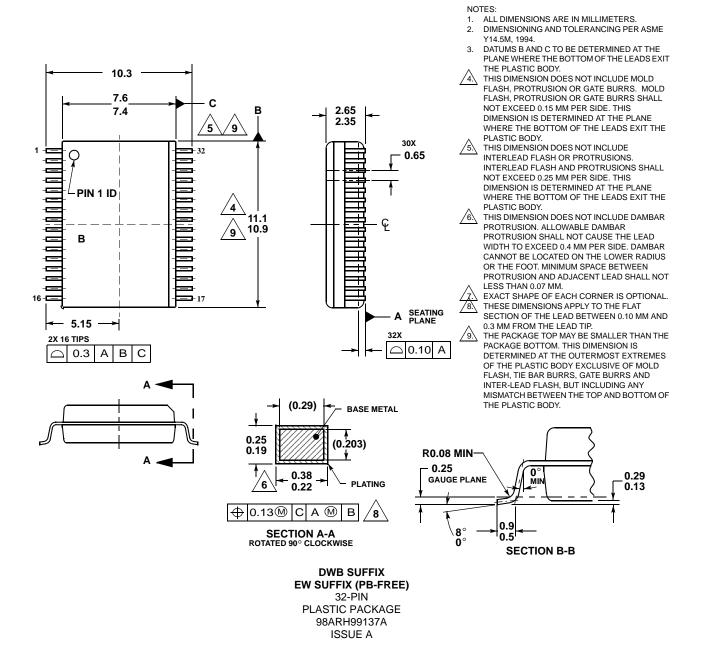


Figure 5. Typical Application Diagram

PACKAGING

PACKAGE DIMENSIONS

For the most current package revision, visit <u>www.freescale.com</u> and perform a keyword search using the 98ARH99137A listed below.



REVISION HISTORY

| REVISION | DATE | DESCRIPTION OF CHANGES |
|----------|--------|--|
| 3.0 | 7/2005 | Implemented Revision History page Converted to Freescale format Added Pin Definitions |
| 4.0 | 2/2007 | Updated Freescale data sheet form and style Added MCZ33395EW/R2 to the Ordering Information block Removed Peak Package Reflow Temperature Dumg Reflow (solder reflow) parameter and added notes ⁽²⁾ and ⁽³⁾ to Maximum Ratings on page 5 |

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USA/Europe or Locations Not Listed:

Freescale Semiconductor, Inc.
Technical Information Center, EL516
2100 East Elliot Road
Tempe, Arizona 85284
+1-800-521-6274 or +1-480-768-2130
www.freescale.com/support

Europe, Middle East, and Africa:

Freescale Halbleiter Deutschland GmbH Technical Information Center Schatzbogen 7 81829 Muenchen, Germany +44 1296 380 456 (English) +46 8 52200080 (English) +49 89 92103 559 (German) +33 1 69 35 48 48 (French) www.freescale.com/support

Japan:

Freescale Semiconductor Japan Ltd. Headquarters ARCO Tower 15F 1-8-1, Shimo-Meguro, Meguro-ku, Tokyo 153-0064 Japan 0120 191014 or +81 3 5437 9125 support.japan@freescale.com

Asia/Pacific:

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Tai Po Industrial Estate
Tai Po, N.T., Hong Kong
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